


<b>Search Notes</b>  	<b>Application/Control No.</b>  10551671	<b>Applicant(s)/Patent Under Reexamination</b>  ADAMEK ET AL.
	<b>Examiner</b>  SHEELA C CHAWAN	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner
382	103, 177, 215, 154, 165, 100, 164, 282, 154, 151, 174, 177, 203, 238, 291, 289, 174, 242, 241, 199,	11/9/08	SCC
714	701	"	"
345	419, 468, 441, 471, E13.005, E13.014, E13.015, E13.016, E13.018, E13.019, E13.025, E13.061, E13.062, E13.071	"	"
375	E7.081	"	"
295	21, 44, 11, 15	"	"
250	559.23	"	"
700	187	"	"

SEARCH NOTES		
Search Notes	Date	Examiner
SEARCH EAST AND OTHER DA TA BASE, SEE THE SEARCH HISTORY.	11/9/08	SCC
SEARCH INVENTOR NAME	"	"

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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